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PATENTS
7391/AKT/DISPLAY/RKK

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s) : Shinichi Kurita
Serial No. : 10/601,098
Filed : June 20, 2003
For : SHARED SENSORS FOR DETECTING SUBSTRATE
POSITION/PRESENCE

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with 37 C.F.R. §§ 1.56 and 1.97,
applicants wish to call the attention of the Examiner to the
following references:

U.S. Patent No. 6,339,730, Matsushima

U.S. Patent No. 6,327,517, Sundar

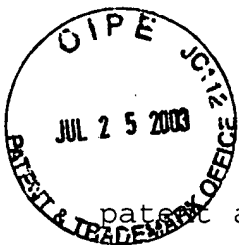
U.S. Patent No. 6,120,601, Landau et al.

U.S. Patent No. 5,917,601, Shimazaki et al.

U.S. Patent No. 5,483,138, Shmookler et al.

U.S. Patent No. 5,452,521, Niewmierzycki

These references are also listed on the accompanying
Information Disclosure Statement (Form PTO-1449) and copies are
enclosed.



Consideration of the foregoing in relation to this
patent application is respectfully requested.

Respectfully Submitted,

A handwritten signature in black ink, appearing to read "Brian M. Dugan".

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Dated:

7/25/03
Tarrytown, New York

U.S. Department of Commerce, Patent and Trademark Office <div style="display: flex; align-items: center;"> <div> LIST OF RELEVANT ART CITED BY APPLICANT (Use several sheets if necessary) </div> </div>					Docket No.: 7391/AKT/DISPLAY/RKK		Serial No.: 10/601,098	
					Applicant(s): Shinichi Kurita			
					Filing Date: 06/20/03		Group: _____	
U.S. Patent Documents								
*Examiner Initial	AA	Document Number	Issue Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	6,339,730	01/15/02	Matsushima				
	AB	6,327,517	12/04/01	Sundar				
	AC	6,120,601	09/19/00	Landau et al.				
	AD	5,917,601	06/29/99	Shimazaki et al.				
	AE	5,483,138	01/09/96	Shmookler et al.				
	AF	5,452,521	09/26/95	Niewmierzycki				
	AG							
	AH							
	AI							
	AJ							
	AK							
Foreign Patent Documents								
							Translation	
		Document Number	Date	Country	Class	Subclass	Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
	AT							
Examiner			Date Considered					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.								